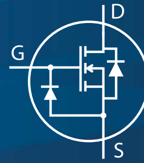
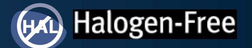
EPC2219 – Enhancement Mode Power Transistor with Integrated Reverse Gate Clamp Diode

V_{DS} , 65 V
$R_{DS(on)}$, 3300 mΩ
I_D , 0.5 A
AEC-Q101





Revised February 26, 2021

Gallium Nitride's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(on)}$, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR}. The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

Questions: Ask a GaN Expert

Maximum Ratings

	PARAMETER	VALUE	UNIT
V_{DS}	Drain-to-Source Voltage (Continuous)	65	V
I_D	Continuous (T_A = 25°C)	0.5	A
	Pulsed (25°C, T_{PULSE} = 300 µs)	0.5	
V_{GS}	Gate-to-Source Voltage	5.75	V
T_J	Operating Temperature	-40 to 150	°C
T_{STG}	Storage Temperature	-40 to 150	

Thermal Characteristics

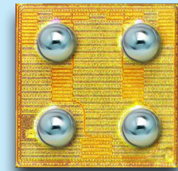
	PARAMETER	TYP	UNIT
$R_{θJC}$	Thermal Resistance, Junction-to-Case	20	°C/W
$R_{θJB}$	Thermal Resistance, Junction-to-Board	91	
$R_{θJA}$	Thermal Resistance, Junction-to-Ambient (Note 1)	100	

Note 1: $R_{θJA}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board.
See https://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details.

Static Characteristics (T_J = 25°C unless otherwise stated)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
BV_{DSS}	Drain-to-Source Voltage	V_{GS} = 0 V, I_D = 100 µA	65			V
I_{DSS}	Drain-Source Leakage	V_{DS} = 65 V, V_{GS} = 0 V		20	100	µA
I_{GSS}	Gate-to-Source Forward Leakage	V_{GS} = 5 V		0.1	500	
	Gate-to-Source Forward Leakage#	V_{GS} = 5 V, T_J = 125˚C		2	1000	
V_F	Source-Gate Forward Voltage	I_F = 0.2 mA, V_{DS} = 0 V		1.8		V
$V_{GS(TH)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 0.1 mA	0.8	1.6	2.5	V
$R_{DS(on)}$	Drain-Source On Resistance	V_{GS} = 5 V, I_D = 0.05 A		1700	3300	mΩ
V_{SD}	Source-Drain Forward Voltage#	I_S = 0.1 A, V_{GS} = 0 V		3.1		V

Defined by design. Not subject to production test.



Die size: 0.9 x 0.9 mm

EPC2219 eGaN® FETs are supplied only in passivated die form with solder bumps.

Applications

- Lidar/pulsed power applications
- High speed gate driving
- Wireless power transfer
- Synchronous bootstrap
- Class-D audio

Benefits

- Ultra high efficiency
- Ultra low Q_G
- Ultra small footprint

Scan QR code or click link below for more information including reliability reports, device models, demo boards!

https://l.ead.me/EPC2219

Dynamic Characteristics# (T_J = 25°C unless otherwise stated)						
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
C_{ISS}	Input Capacitance	V_{DS} = 32.5 V, V_{GS} = 0 V		7	10	pF
C_{RSS}	Reverse Transfer Capacitance			0.013		
C_{OSS}	Output Capacitance			2	3	
$C_{OSS(ER)}$	Effective Output Capacitance, Energy Related (Note 2)	V_{DS} = 0 to 32.5 V, V_{GS} = 0 V		3		
$C_{OSS(TR)}$	Effective Output Capacitance, Time Related (Note 3)			3.5		
R_G	Gate Resistance			4.8		Ω
Q_G	Total Gate Charge	V_{DS} = 32.5 V, V_{GS} = 5 V, I_D = 0.05 A		49	64	pC
Q_{GS}	Gate-to-Source Charge	V_{DS} = 32.5 V, I_D = 0.05 A		23		
Q_{GD}	Gate-to-Drain Charge			3.7		
$Q_{G(TH)}$	Gate Charge at Threshold			19		
Q_{OSS}	Output Charge	V_{DS} = 32.5 V, V_{GS} = 0 V		114	171	
Q_{RR}	Source-Drain Recovery Charge			0		

Defined by design. Not subject to production test.
All measurements were done with substrate connected to source.
Note 2: $C_{OSS(ER)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.
Note 3: $C_{OSS(TR)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.

Figure 1: Typical Output Characteristics at 25°C

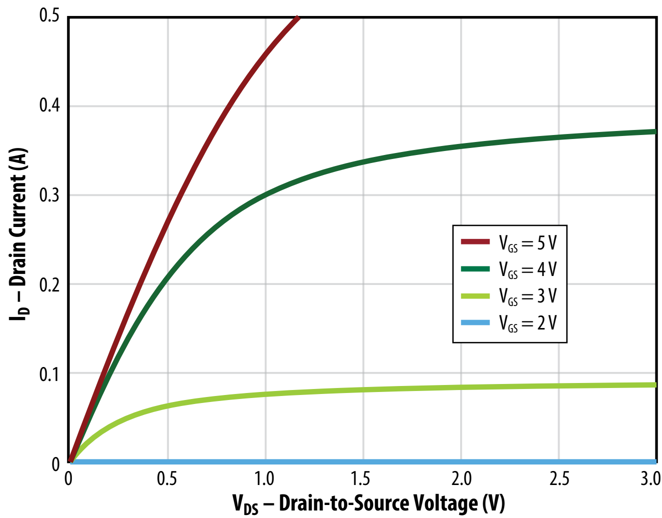


Figure 2: Typical Transfer Characteristics

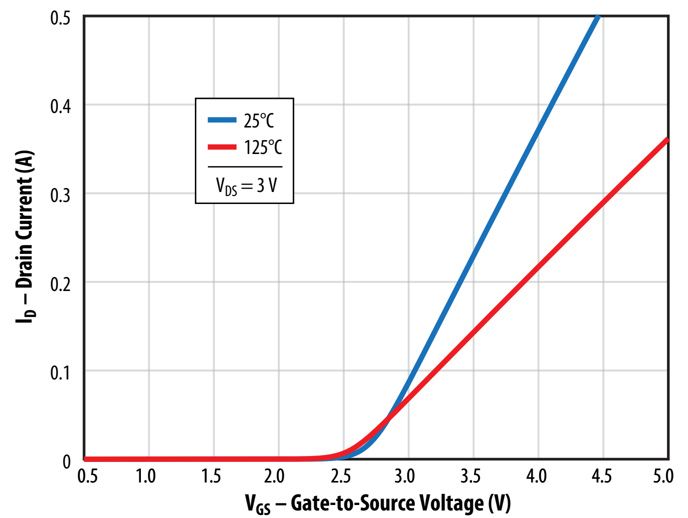


Figure 3: Typical $R_{DS(on)}$ vs. V_{GS} for Various Drain Currents

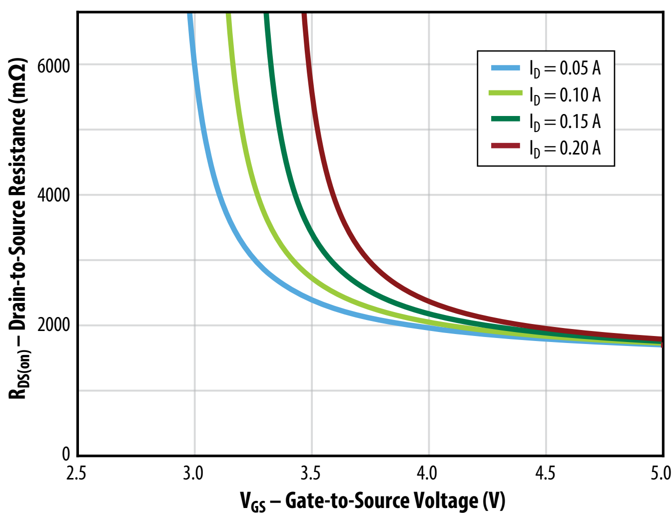


Figure 4: Typical $R_{DS(on)}$ vs. V_{GS} for Various Temperatures

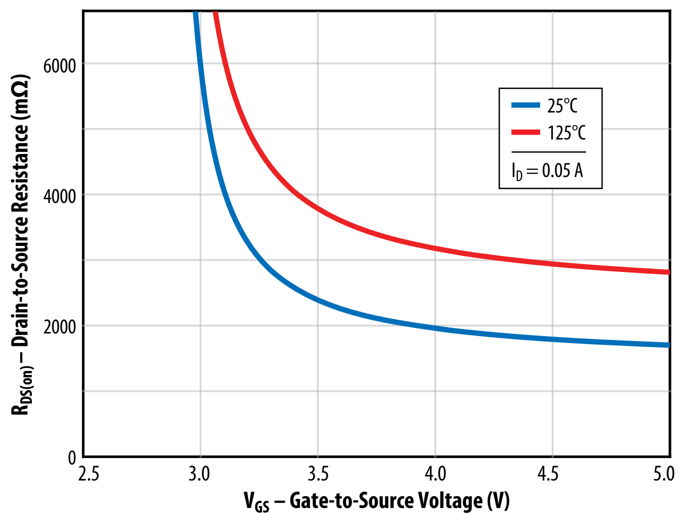


Figure 5a: Typical Capacitance (Linear Scale)

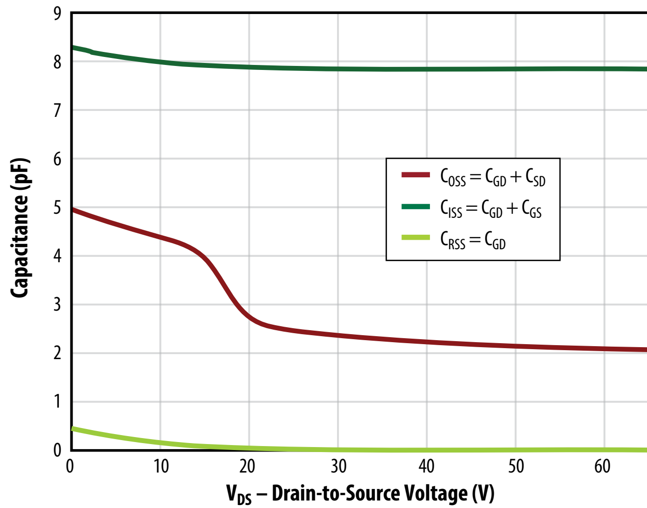


Figure 5b: Typical Capacitance (Log Scale)

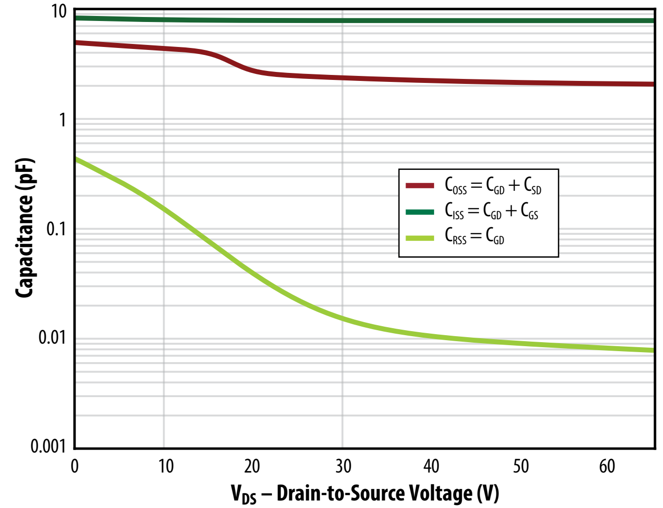


Figure 6: Typical Output Charge and C_{OSS} Stored Energy

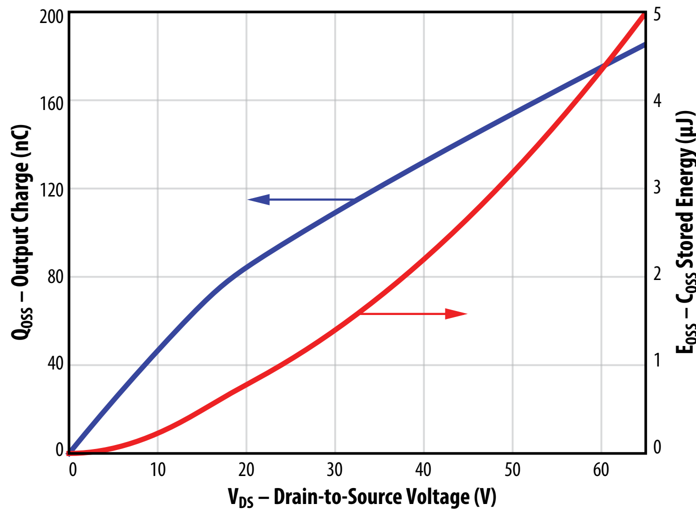


Figure 7: Typical Gate Charge

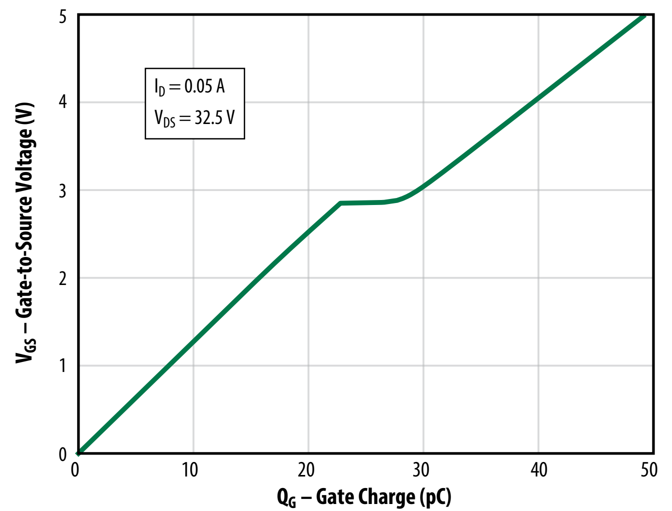
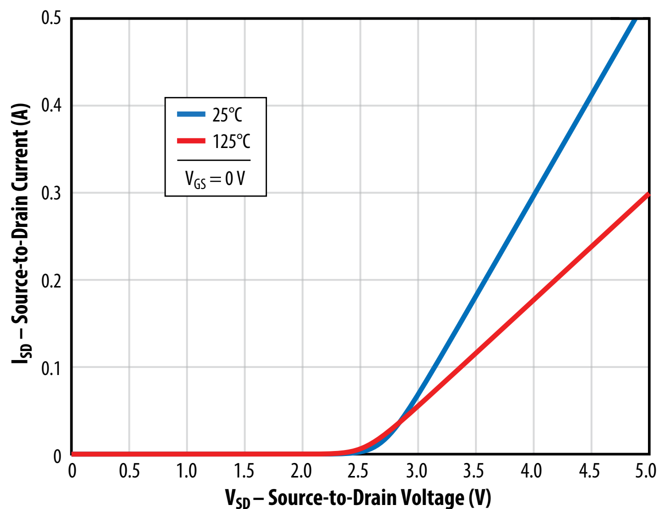


Figure 8: Typical Reverse Drain-Source Characteristics



Note: Negative gate drive voltage increases the reverse drain-source voltage. EPC recommends 0 V for OFF.

Figure 9: Typical Normalized On-State Resistance vs. Temp.

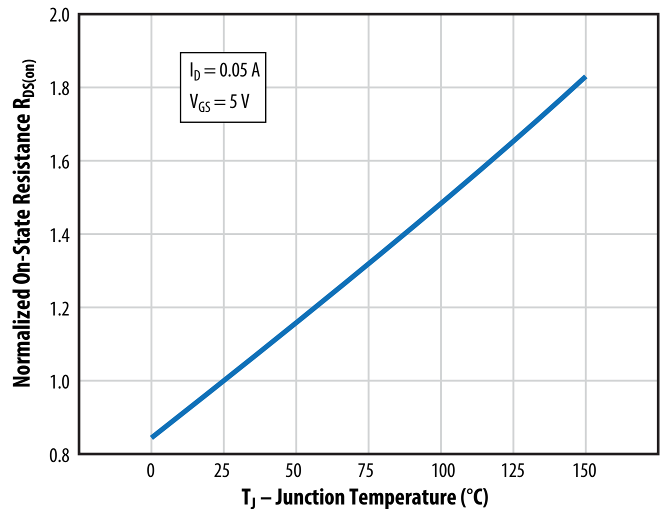


Figure 10: Typical Normalized Threshold Voltage vs. Temp.

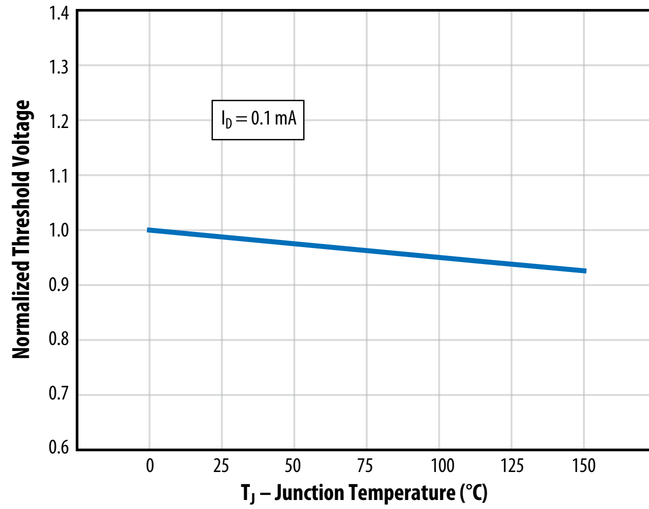


Figure 11: Safe Operating Area

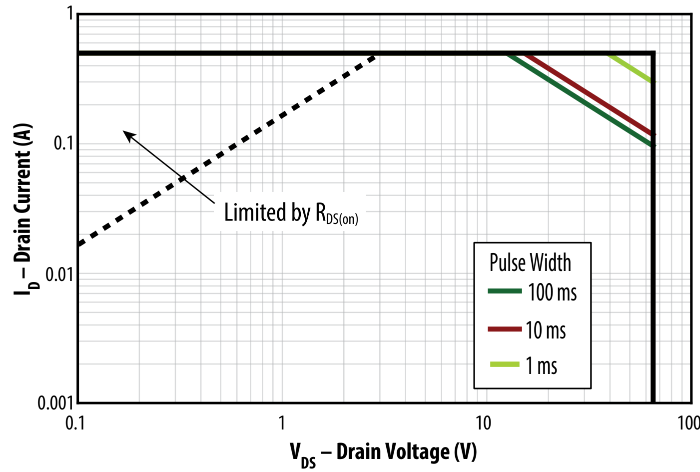
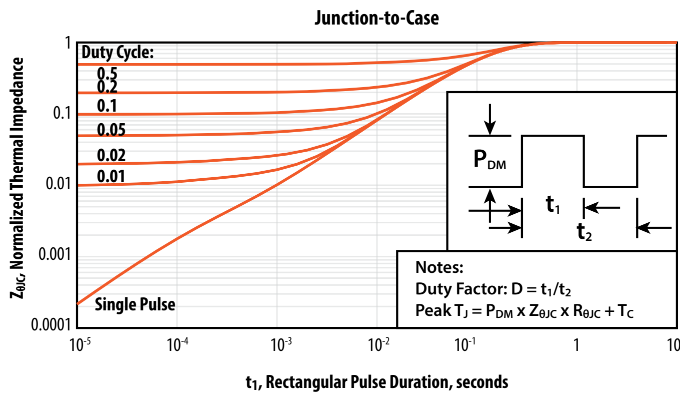
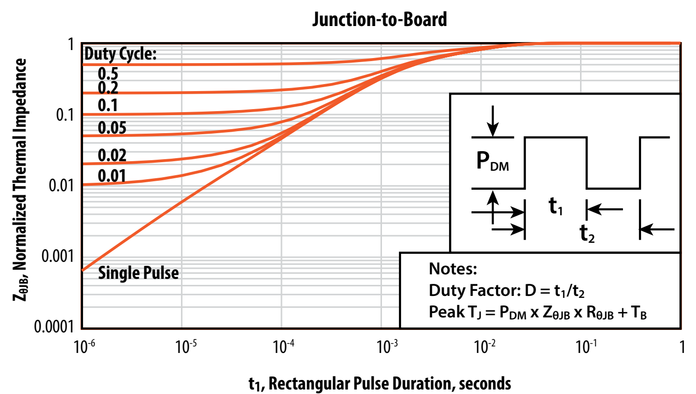


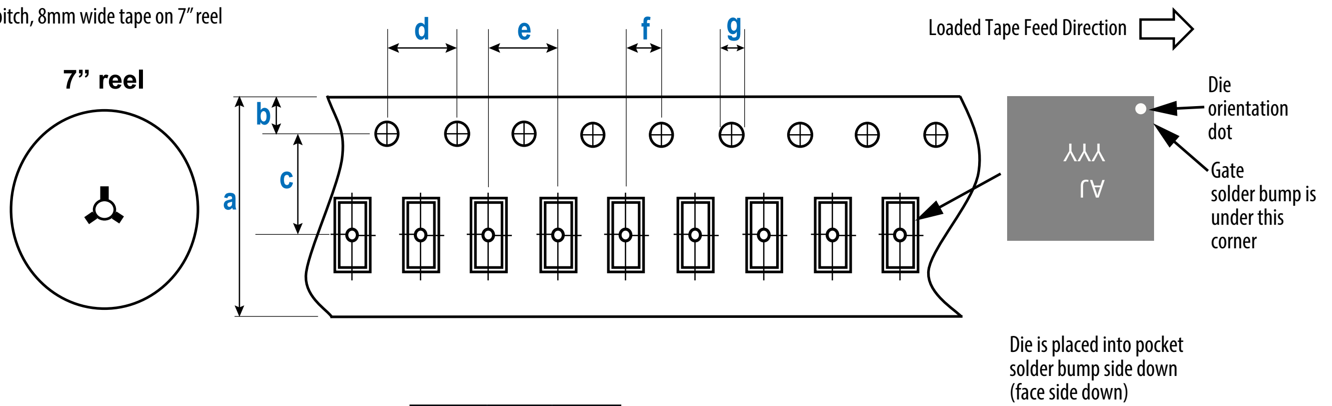
Figure 12: Typical Transient Thermal Response Curves





TAPE AND REEL CONFIGURATION

4mm pitch, 8mm wide tape on 7" reel

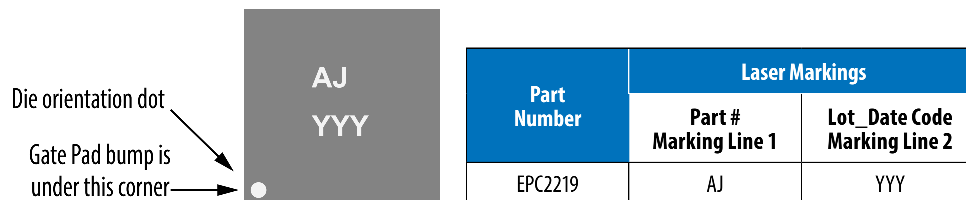


EPC2219 (Note 1)	Dimension (mm) Target	MIN	MAX
a	8.00	7.90	8.30
b	1.75	1.65	1.85
c (Note 2)	3.50	3.45	3.55
d	4.00	3.90	4.10
e	4.00	3.90	4.10
f (Note 2)	2.00	1.95	2.05
g	1.50	1.50	1.60

Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard.

Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

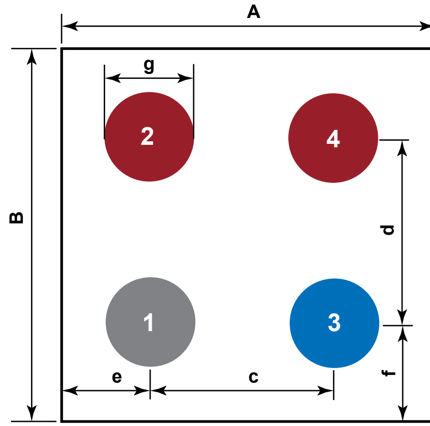
DIE MARKINGS



Part Number	Laser Markings Part # Marking Line 1	Lot_Date Code Marking Line 2
EPC2219	AJ	YYY

DIE OUTLINE

Solder Bump View



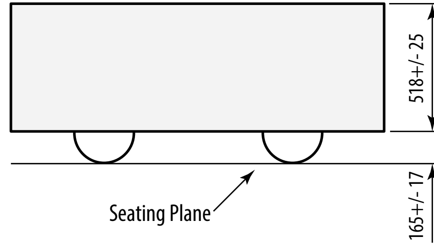
DIM	MIN	Nominal	MAX
A	870	900	930
B	870	900	930
c	450	450	450
d	450	450	450
e	210	225	240
f	210	225	240
g	187	208	229

Pads 1 is Gate;

Pad 3 is Drain;

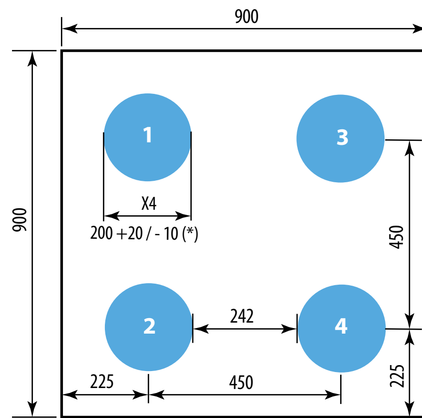
Pads 2, 4 are Source

Side View



RECOMMENDED LAND PATTERN

(measurements in µm)



* minimum 190

The land pattern is solder mask defined.

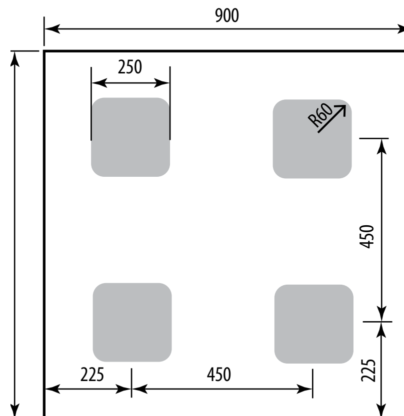
Pads 1 is Gate;

Pad 3 is Drain;

Pads 2, 4 are Source

RECOMMENDED STENCIL DRAWING

(measurements in µm)



Recommended stencil should be 4 mil (100 µm) thick, must be laser cut, openings per drawing.

Intended for use with SAC305 Type 4 solder, reference 88.5% metals content.

Additional assembly resources available at https://epc-co.com/epc/design-support

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